

TLC2543C, TLC2543I, TLC2543M

12-BIT ANALOG-TO-DIGITAL CONVERTERS

WITH SERIAL CONTROL AND 11 ANALOG INPUTS

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- 12-Bit-Resolution A/D Converter
- 10- μ s Conversion Time Over Operating Temperature
- 11 Analog Input Channels
- 3 Built-In Self-Test Modes
- Inherent Sample-and-Hold Function
- Linearity Error . . . ± 1 LSB Max
- On-Chip System Clock
- End-of-Conversion Output
- Unipolar or Bipolar Output Operation (Signed Binary With Respect to 1/2 the Applied Voltage Reference)
- Programmable MSB or LSB First
- Programmable Power Down
- Programmable Output Data Length
- CMOS Technology
- Application Report Available[†]

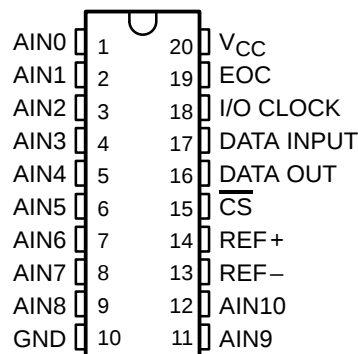
description

The TLC2543C and TLC2543I are 12-bit, switched-capacitor, successive-approximation, analog-to-digital converters. Each device, with three control inputs [chip select ($\overline{CS}$), the input-output clock, and the address input (DATA INPUT)], is designed for communication with the serial port of a host processor or peripheral through a serial 3-state output. The device allows high-speed data transfers from the host.

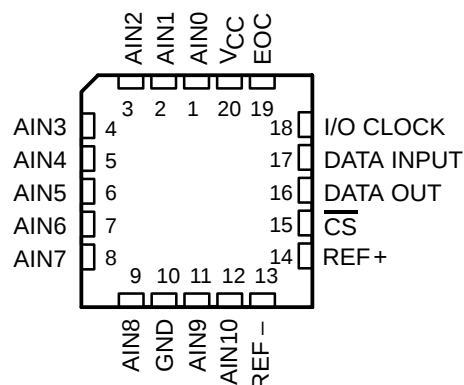
In addition to the high-speed converter and versatile control capability, the device has an on-chip 14-channel multiplexer that can select any one of 11 inputs or any one of three internal self-test voltages. The sample-and-hold function is automatic. At the end of conversion, the end-of-conversion (EOC) output goes high to indicate that conversion is complete. The converter incorporated in the device features differential high-impedance reference inputs that facilitate ratiometric conversion, scaling, and isolation of analog circuitry from logic and supply noise. A switched-capacitor design allows low-error conversion over the full operating temperature range.

The TLC2543C is characterized for operation from $T_A = 0^\circ\text{C}$ to 70°C . The TLC2543I is characterized for operation from $T_A = -40^\circ\text{C}$ to 85°C . The TLC2543M is characterized for operation from $T_A = -55^\circ\text{C}$ to 125°C .

DB, DW, J, OR N PACKAGE
(TOP VIEW)



FN PACKAGE
(TOP VIEW)



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

[†] Microcontroller Based Data Acquisition Using the TLC2543 12-bit Serial-Out ADC (SLAA012)

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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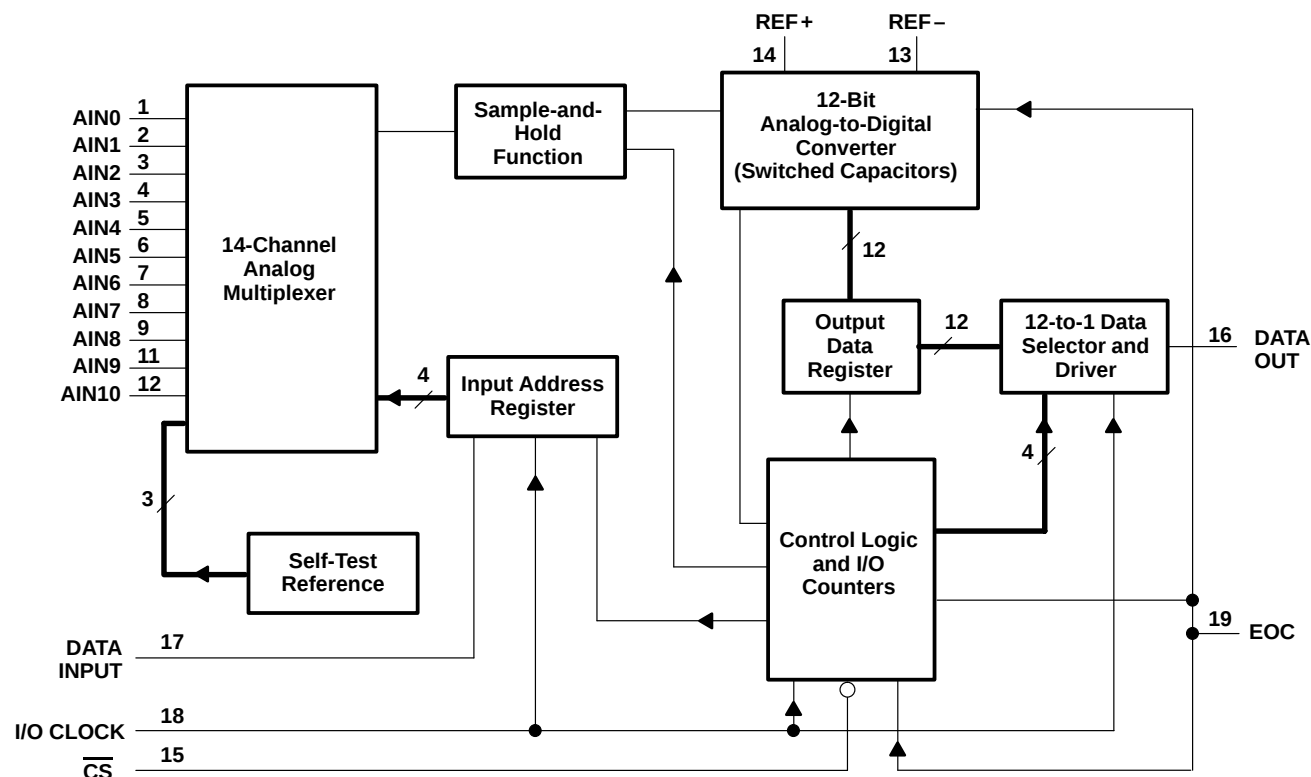
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AVAILABLE OPTIONS

T _A	PACKAGE				
	SMALL OUTLINE		PLASTIC CHIP CARRIER	CERAMIC DIP	PLASTIC DIP
	(DB) [†]	(DW) [†]	(FN) [†]	(J)	(N)
0°C to 70°C	TLC2543CDB	TLC2543CDW	TLC2543CFN	—	TLC2543CN
–40°C to 85°C	TLC2543IDB	TLC2543IDW	TLC2543IFN	—	TLC2543IN
–55°C to 125°C	—	—	—	TLC2543MJ	—

[†] Available in tape and reel and ordered as the TLC2543CDBLE, TLC2543IDBR, TLC2543CDWR, TLC2543IDWR, TLC2543CFNR, or TLC2543IFNR.

functional block diagram



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Terminal Functions

TERMINAL NAME	NO.	I/O	DESCRIPTION
AIN0 – AIN10	1–9, 11, 12	I	Analog input. These 11 analog-signal inputs are internally multiplexed. The driving source impedance should be less than or equal to 50 Ω for 4.1-MHz I/O CLOCK operation and be capable of slewing the analog input voltage into a capacitance of 60 pF.
$\overline{\text{CS}}$	15	I	Chip select. A high-to-low transition on $\overline{\text{CS}}$ resets the internal counters and controls and enables DATA OUT, DATA INPUT, and I/O CLOCK. A low-to-high transition disables DATA INPUT and I/O CLOCK within a setup time.
DATA INPUT	17	I	Serial-data input. A 4-bit serial address selects the desired analog input or test voltage to be converted next. The serial data is presented with the MSB first and is shifted in on the first four rising edges of I/O CLOCK. After the four address bits are read into the address register, I/O CLOCK clocks the remaining bits in order.
DATA OUT	16	O	The 3-state serial output for the A/D conversion result. DATA OUT is in the high-impedance state when $\overline{\text{CS}}$ is high and active when $\overline{\text{CS}}$ is low. With a valid $\overline{\text{CS}}$, DATA OUT is removed from the high-impedance state and is driven to the logic level corresponding to the MSB/LSB [†] value of the previous conversion result. The next falling edge of I/O CLOCK drives DATA OUT to the logic level corresponding to the next MSB/LSB, and the remaining bits are shifted out in order.
EOC	19	O	End of conversion. EOC goes from a high to a low logic level after the falling edge of the last I/O CLOCK and remains low until the conversion is complete and the data is ready for transfer.
GND	10		Ground. GND is the ground return terminal for the internal circuitry. Unless otherwise noted, all voltage measurements are with respect to GND.
I/O CLOCK	18	I	Input/output clock. I/O CLOCK receives the serial input and performs the following four functions: 1. It clocks the eight input data bits into the input data register on the first eight rising edges of I/O CLOCK with the multiplexer address available after the fourth rising edge. 2. On the fourth falling edge of I/O CLOCK, the analog input voltage on the selected multiplexer input begins charging the capacitor array and continues to do so until the last falling edge of the I/O CLOCK. 3. It shifts the 11 remaining bits of the previous conversion data out on DATA OUT. Data changes on the falling edge of I/O CLOCK. 4. It transfers control of the conversion to the internal state controller on the falling edge of the last I/O CLOCK.
REF+	14	I	Positive reference voltage. The upper reference voltage value (nominally V_{CC}) is applied to REF+. The maximum input voltage range is determined by the difference between the voltage applied to this terminal and the voltage applied to the REF– terminal.
REF–	13	I	Negative reference voltage. The lower reference voltage value (nominally ground) is applied to REF–.
VCC	20		Positive supply voltage

[†] MSB/LSB = Most significant bit / least significant bit

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC} (see Note 1)	–0.5 V to 6.5 V
Input voltage range, V_I (any input)	–0.3 V to $V_{CC} + 0.3$ V
Output voltage range, V_O	–0.3 V to $V_{CC} + 0.3$ V
Positive reference voltage, V_{ref+}	$V_{CC} + 0.1$ V
Negative reference voltage, V_{ref-}	–0.1 V
Peak input current, I_I (any input)	±20 mA
Peak total input current, I_I (all inputs)	±30 mA
Operating free-air temperature range, T_A : TLC2543C	0°C to 70°C
TLC2543I	–40°C to 85°C
TLC2543M	–55°C to 125°C
Storage temperature range, T_{stg}	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from the case for 10 seconds	260°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to the GND terminal with REF– and GND wired together (unless otherwise noted).

recommended operating conditions

		MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		4.5	5	5.5	V
Positive reference voltage, V _{ref+} (see Note 2)		V _{CC}			V
Negative reference voltage, V _{ref−} (see Note 2)		0			V
Differential reference voltage, V _{ref+} − V _{ref−} (see Note 2)		2.5	V _{CC}	V _{CC} +0.1	V
Analog input voltage (see Note 2)		0	V _{CC}		V
High-level control input voltage, V _{IH}	V _{CC} = 4.5 V to 5.5 V	2			V
Low-level control input voltage, V _{IL}	V _{CC} = 4.5 V to 5.5 V		0.8		V
Clock frequency at I/O CLOCK		0	4.1		MHz
Setup time, address bits at DATA INPUT before I/O CLOCK↑, t _{su(A)} (see Figure 4)		100			ns
Hold time, address bits after I/O CLOCK↑, t _{h(A)} (see Figure 4)		0			ns
Hold time, $\overline{CS}$ low after last I/O CLOCK↓, t _{h(CS)} (see Figure 5)		0			ns
Setup time, $\overline{CS}$ low before clocking in first address bit, t _{su(CS)} (see Note 3 and Figure 5)		1.425			μs
Pulse duration, I/O CLOCK high, t _{wH(I/O)}		120			ns
Pulse duration, I/O CLOCK low, t _{wL(I/O)}		120			ns
Transition time, I/O CLOCK high to low, t _{t(I/O)} (see Note 4 and Figure 6)			1		μs
Transition time, DATA INPUT and $\overline{CS}$, t _{t(CS)}			10		μs
Operating free-air temperature, T _A	TLC2543C	0	70		°C
	TLC2543I	−40	85		
	TLC2543M	−55	125		

NOTES: 2. Analog input voltages greater than that applied to REF+ convert as all ones (1111111111), while input voltages less than that applied to REF– convert as all zeros (000000000000).

3. To minimize errors caused by noise at the $\overline{CS}$ input, the internal circuitry waits for a setup time after $\overline{CS}$ [↓] before responding to control input signals. No attempt should be made to clock in an address until the minimum $\overline{CS}$ setup time has elapsed.

4. This is the time required for the clock input signal to fall from V_{IHmin} to V_{ILmax} or to rise from V_{ILmax} to V_{IHmin} . In the vicinity of normal room temperature, the devices function with input clock transition time as slow as 1 μs for remote data acquisition applications where the sensor and the A/D converter are placed several feet away from the controlling microprocessor.



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electrical characteristics over recommended operating free-air temperature range,
 $V_{CC} = V_{ref+} = 4.5\text{ V to }5.5\text{ V}$, $f_{(I/O\text{ CLOCK})} = 4.1\text{ MHz}$ (unless otherwise noted)

PARAMETER			TEST CONDITIONS	TLC2543C, TLC2543I			UNIT
				MIN	TYP†	MAX	
V _{OH}	High-level output voltage		V _{CC} = 4.5 V, I _{OH} = −1.6 mA	2.4			V
			V _{CC} = 4.5 V to 5.5 V, I _{OH} = −20 μA	V _{CC} − 0.1			
V _{OL}	Low-level output voltage		V _{CC} = 4.5 V, I _{OL} = 1.6 mA	0.4			V
			V _{CC} = 4.5 V to 5.5 V, I _{OL} = 20 μA	0.1			
I _{OZ}	High-impedance off-state output current		V _O = V _{CC} , $\overline{\text{CS}}$ at V _{CC}	1	2.5	μA	
			V _O = 0, $\overline{\text{CS}}$ at V _{CC}	1	−2.5		
I _{IH}	High-level input current		V _I = V _{CC}	1	2.5	μA	
I _{IL}	Low-level input current		V _I = 0	1	−2.5	μA	
I _{CC}	Operating supply current		$\overline{\text{CS}}$ at 0 V	1	2.5	mA	
I _{CC(PD)}	Power-down current		For all digital inputs, 0 ≤ V _I ≤ 0.5 V or V _I ≥ V _{CC} − 0.5 V	4	25	μA	
Selected channel leakage current			Selected channel at V _{CC} , Unselected channel at 0 V	1			μA
			Selected channel at 0 V, Unselected channel at V _{CC}	−1			
Maximum static analog reference current into REF +			V _{ref+} = V _{CC} , V _{ref−} = GND	1	2.5	μA	
C _i	Input capacitance	Analog inputs		30	60	pF	
		Control inputs		5	15		

† All typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.

electrical characteristics over recommended operating free-air temperature range,
 $V_{CC} = V_{ref+} = 4.5\text{ V to }5.5\text{ V}$, $f_{(I/O\text{ CLOCK})} = 4.1\text{ MHz}$ (unless otherwise noted)

PARAMETER			TEST CONDITIONS	TLC2543M			UNIT
				MIN	TYP†	MAX	
V _{OH}	High-level output voltage		V _{CC} = 4.5 V, I _{OH} = −1.6 mA	2.4			V
			V _{CC} = 4.5 V to 5.5 V, I _{OH} = −20 μA	V _{CC} − 0.1			
V _{OL}	Low-level output voltage		V _{CC} = 4.5 V, I _{OL} = 1.6 mA	0.4			V
			V _{CC} = 4.5 V to 5.5 V, I _{OL} = 20 μA	0.1			
I _{OZ}	High-impedance off-state output current		V _O = V _{CC} , $\overline{\text{CS}}$ at V _{CC}	1	2.5	μA	
			V _O = 0, $\overline{\text{CS}}$ at V _{CC}	1	−2.5		
I _{IH}	High-level input current		V _I = V _{CC}	1	10	μA	
I _{IL}	Low-level input current		V _I = 0	1	−10	μA	
I _{CC}	Operating supply current		$\overline{\text{CS}}$ at 0 V	1	2.5	mA	
I _{CC(PD)}	Power-down current		For all digital inputs, 0 ≤ V _I ≤ 0.5 V or V _I ≥ V _{CC} − 0.5 V	4	25	μA	
Selected channel leakage current			Selected channel at V _{CC} , Unselected channel at 0 V	10			μA
			Selected channel at 0 V, Unselected channel at V _{CC}	−10			
Maximum static analog reference current into REF+			V _{ref+} = V _{CC} , V _{ref−} = GND	1	2.5	μA	
C _i	Input capacitance	Analog inputs		30	60	pF	
		Control inputs		5	15		

† All typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.



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operating characteristics over recommended operating free-air temperature range,
 $V_{CC} = V_{ref+} = 4.5 \text{ V to } 5.5 \text{ V}$, $f_{(I/O \text{ CLOCK})} = 4.1 \text{ MHz}$

PARAMETER	TEST CONDITIONS	MIN	TYP [†]	MAX	UNIT
E_L Linearity error (see Note 5)	See Figure 2			± 1	LSB
E_D Differential linearity error	See Figure 2			± 1	LSB
E_O Offset error (see Note 6)	See Note 2 and Figure 2			± 1.5	LSB
E_G Gain error (see Note 6)	See Note 2 and Figure 2			± 1	LSB
E_T Total unadjusted error (see Note 7)				± 1.75	LSB
Self-test output code (see Table 3 and Note 8)	DATA INPUT = 1011		2048		
	DATA INPUT = 1100		0		
	DATA INPUT = 1101		4095		
$t_{(conv)}$ Conversion time	See Figures 9–14		8	10	μs
t_c Total cycle time (access, sample, and conversion)	See Figures 9–14 and Note 9			10 + total I/O CLOCK periods + $t_{d(I/O-EOC)}$	μs
t_{acq} Channel acquisition time (sample)	See Figures 9–14 and Note 9	4		12	I/O CLOCK periods
t_v Valid time, DATA OUT remains valid after I/O CLOCK $\downarrow$	See Figure 6	10			ns
$t_{d(I/O-DATA)}$ Delay time, I/O CLOCK $\downarrow$ to DATA OUT valid	See Figure 6			150	ns
$t_{d(I/O-EOC)}$ Delay time, last I/O CLOCK $\downarrow$ to EOC $\downarrow$	See Figure 7		1.5	2.2	μs
$t_{d(EOC-DATA)}$ Delay time, EOC $\uparrow$ to DATA OUT (MSB/LSB)	See Figure 8			100	ns
t_{pZH}, t_{pZL} Enable time, $\overline{CS}\downarrow$ to DATA OUT (MSB/LSB driven)	See Figure 3		0.7	1.3	μs
t_{pHZ}, t_{pLZ} Disable time, $\overline{CS}\uparrow$ to DATA OUT (high impedance)	See Figure 3		70	150	ns
$t_{r(EOC)}$ Rise time, EOC	See Figure 8		15	50	ns
$t_{f(EOC)}$ Fall time, EOC	See Figure 7		15	50	ns
$t_{r(bus)}$ Rise time, data bus	See Figure 6		15	50	ns
$t_{f(bus)}$ Fall time, data bus	See Figure 6		15	50	ns
$t_{d(I/O-CS)}$ Delay time, last I/O CLOCK $\downarrow$ to $\overline{CS}\downarrow$ to abort conversion (see Note 10)				5	μs

[†] All typical values are at $T_A = 25^\circ\text{C}$.

NOTES: 2. Analog input voltages greater than that applied to REF+ convert as all ones (1111111111), while input voltages less than that applied to REF– convert as all zeros (000000000000).

5. Linearity error is the maximum deviation from the best straight line through the A/D transfer characteristics.

6. Gain error is the difference between the actual midstep value and the nominal midstep value in the transfer diagram at the specified gain point after the offset error has been adjusted to zero. Offset error is the difference between the actual midstep value and the nominal midstep value at the offset point.

7. Total unadjusted error comprises linearity, zero-scale, and full-scale errors.

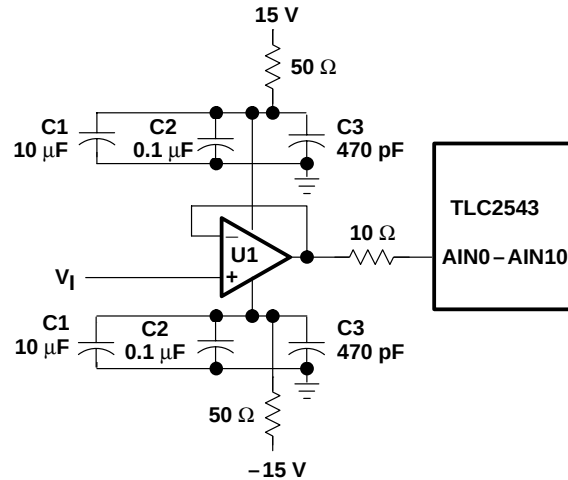
8. Both the input address and the output codes are expressed in positive logic.

9. I/O CLOCK period $\equiv 1/(I/O \text{ CLOCK frequency})$ (see Figure 7).

10. Any transitions of $\overline{CS}$ are recognized as valid only when the level is maintained for a setup time. $\overline{CS}$ must be taken low at $\leq 5 \mu\text{s}$ of the tenth I/O CLOCK falling edge to ensure a conversion is aborted. Between $5 \mu\text{s}$ and $10 \mu\text{s}$, the result is uncertain as to whether the conversion is aborted or the conversion results are valid.



PARAMETER MEASUREMENT INFORMATION



LOCATION	DESCRIPTION	PART NUMBER
U1	OP27	—
C1	10-μF 35-V tantalum capacitor	—
C2	0.1-μF ceramic NPO SMD capacitor	AVX 12105C104KA105 or equivalent
C3	470-pF porcelain Hi-Q SMD capacitor	Johanson 201S420471JG4L or equivalent

Figure 1. Analog Input Buffer to Analog Inputs AIN0–AIN10

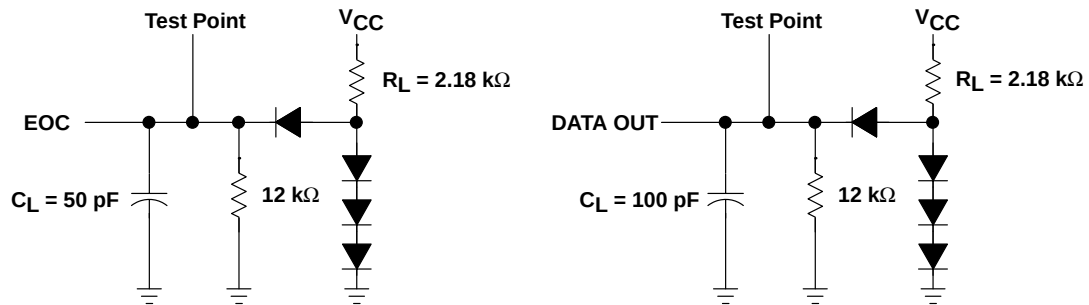


Figure 2. Load Circuits

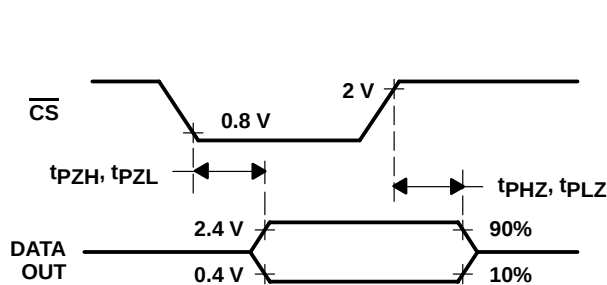


Figure 3. DATA OUT to Hi-Z Voltage Waveforms

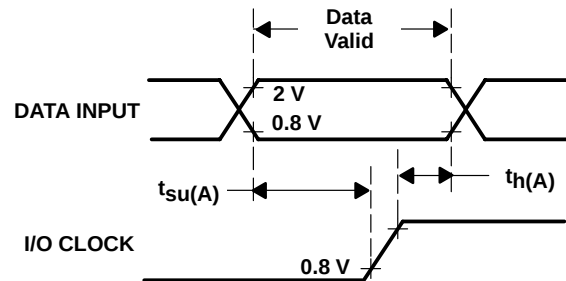


Figure 4. DATA INPUT and I/O CLOCK Voltage Waveforms

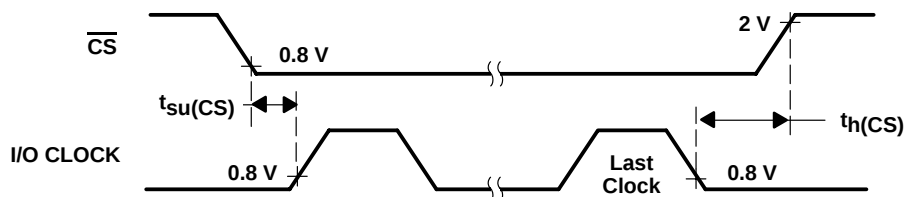
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NOTE A: To ensure full conversion accuracy, it is recommended that no input signal change occurs while a conversion is ongoing.

Figure 5. $\overline{\text{CS}}$ and I/O CLOCK Voltage Waveforms

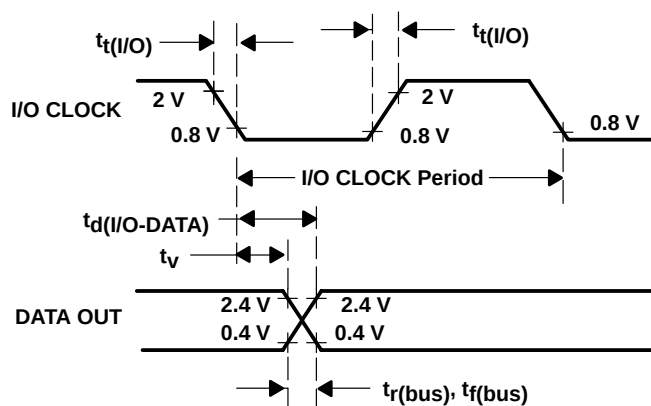


Figure 6. I/O CLOCK and DATA OUT Voltage Waveforms

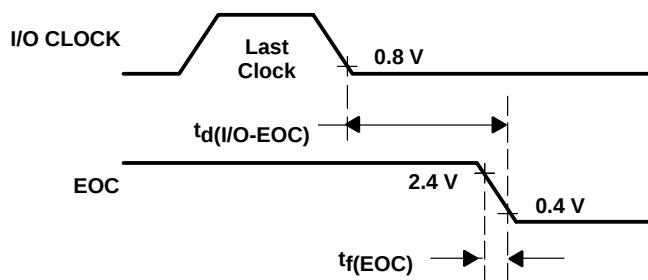


Figure 7. I/O CLOCK and EOC Voltage Waveforms

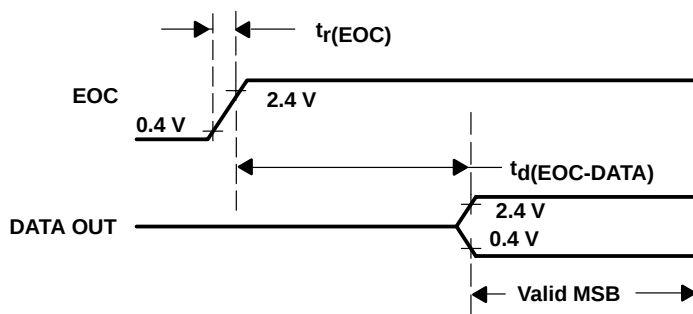
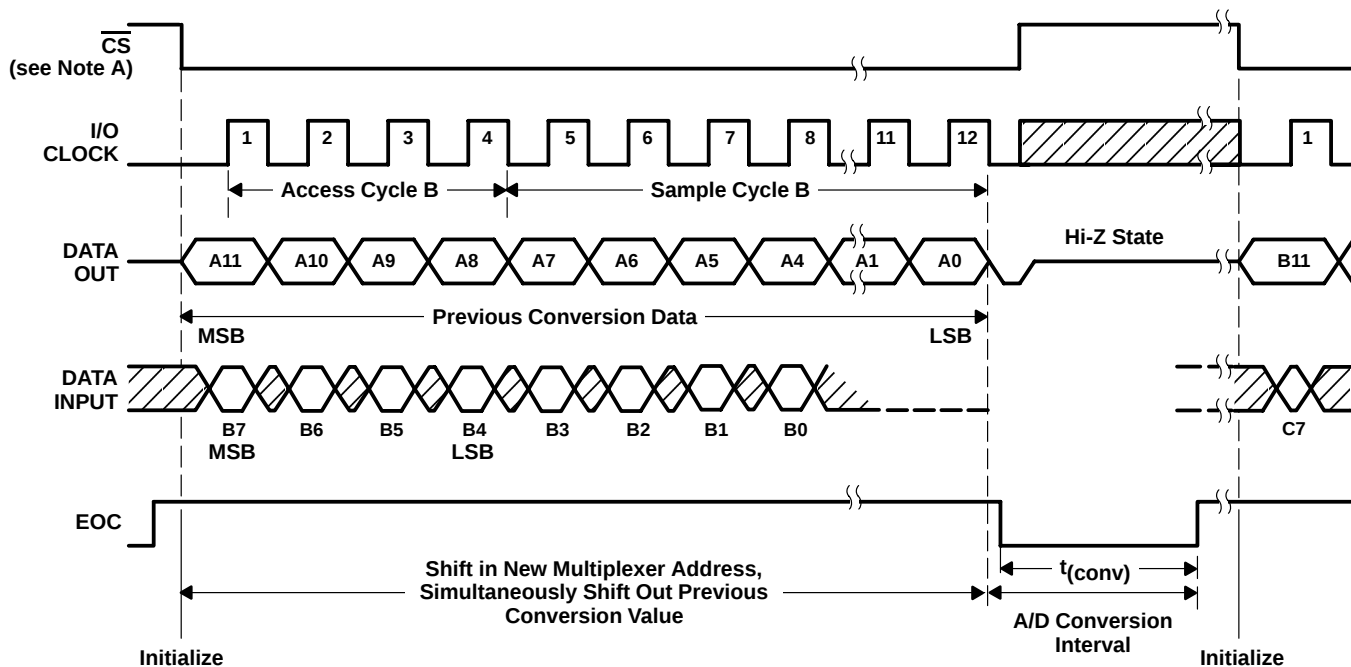


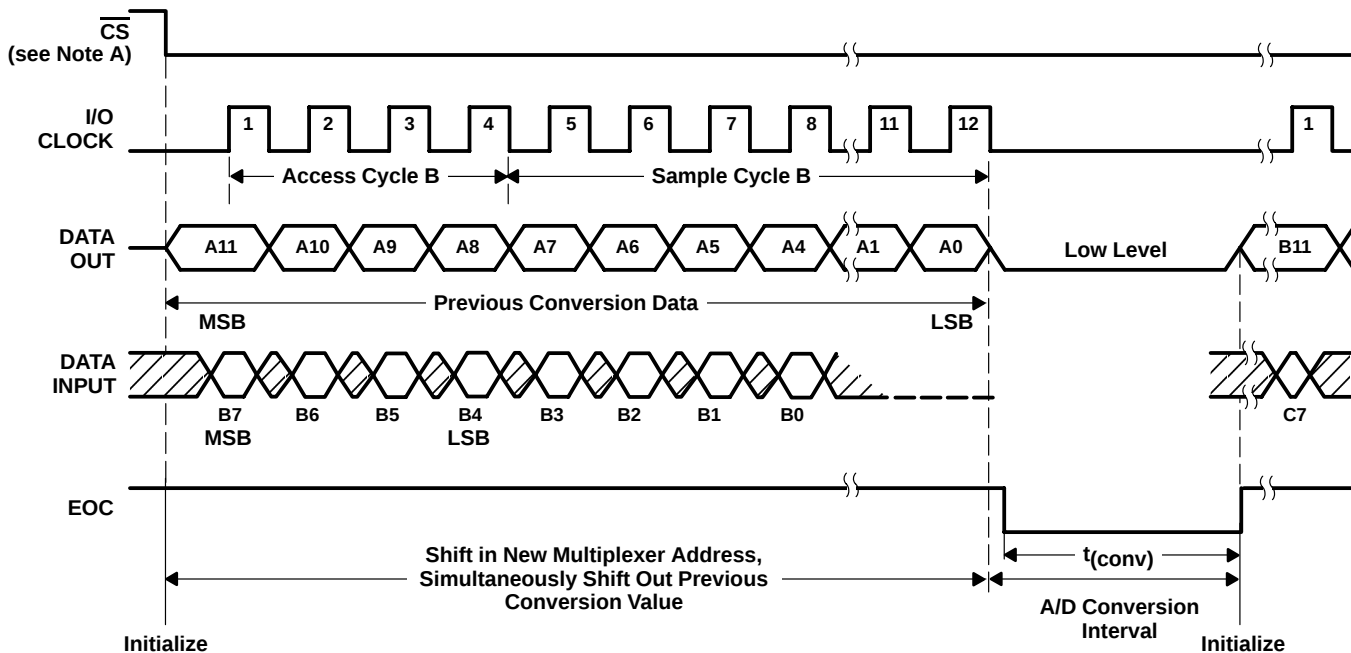
Figure 8. EOC and DATA OUT Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION



NOTE A: To minimize errors caused by noise at $\overline{CS}$, the internal circuitry waits for a setup time after $\overline{CS}\downarrow$ before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum $\overline{CS}$ setup time has elapsed.

Figure 9. Timing for 12-Clock Transfer Using $\overline{CS}$ With MSB First



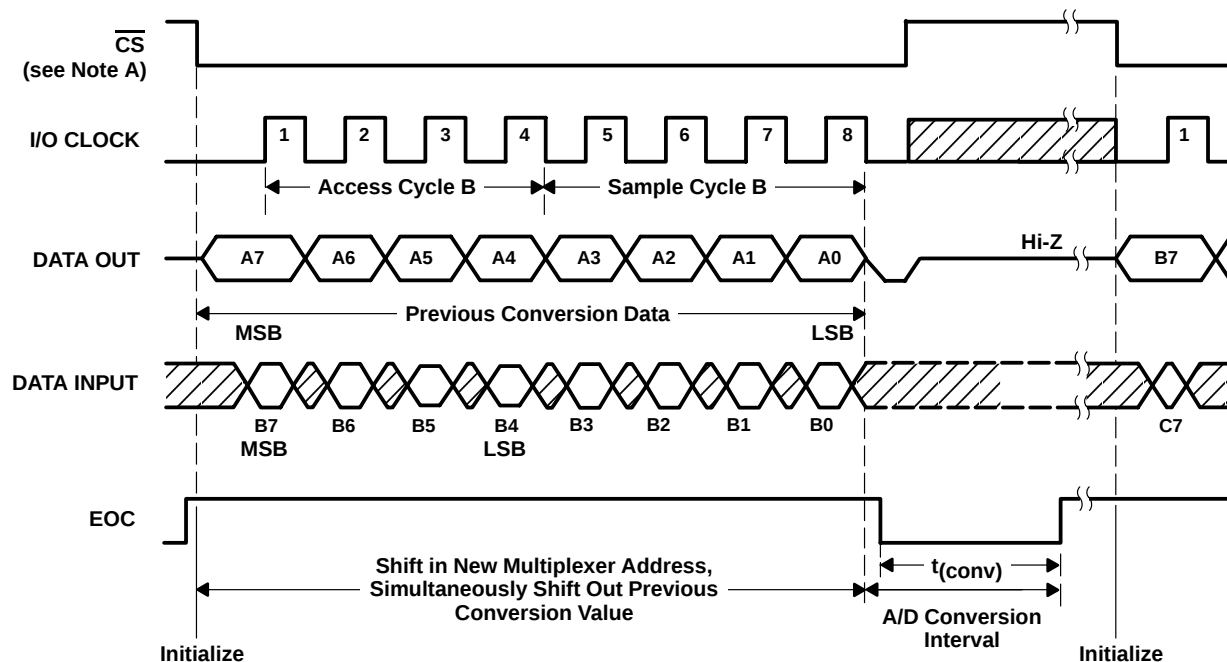
NOTE A: To minimize errors caused by noise at $\overline{CS}$, the internal circuitry waits for a setup time after $\overline{CS}\downarrow$ before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum $\overline{CS}$ setup time has elapsed.

Figure 10. Timing for 12-Clock Transfer Not Using $\overline{CS}$ With MSB First

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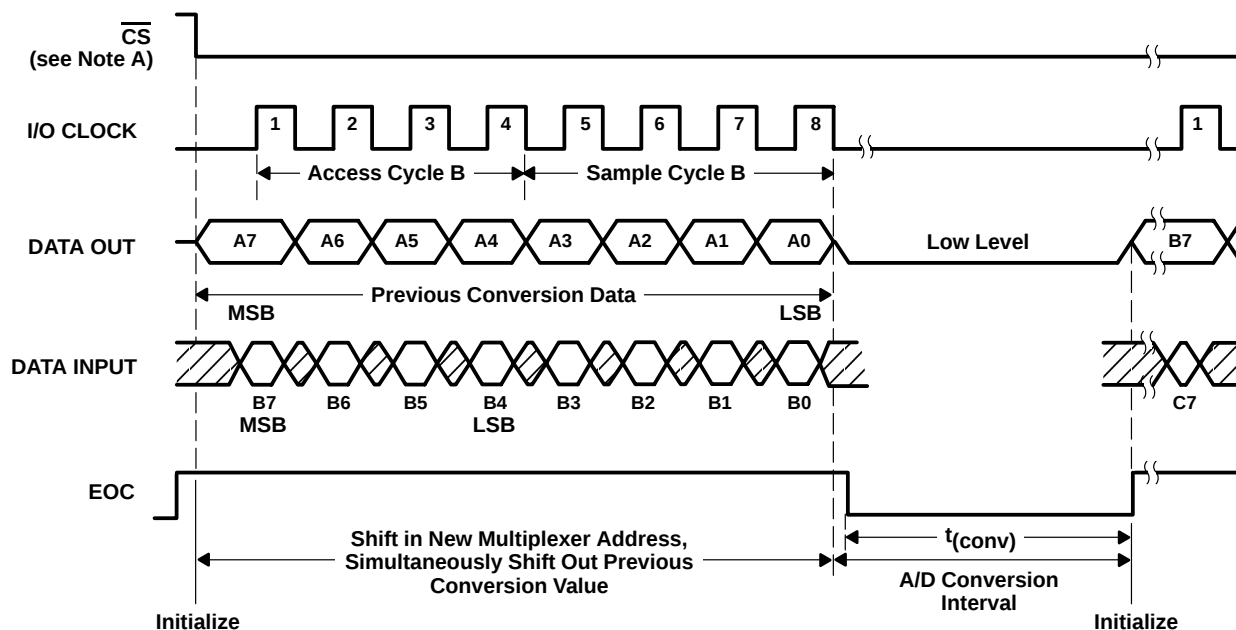
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NOTE A: To minimize errors caused by noise at $\overline{CS}$, the internal circuitry waits for a setup time after $\overline{CS}\downarrow$ before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum $\overline{CS}$ setup time has elapsed.

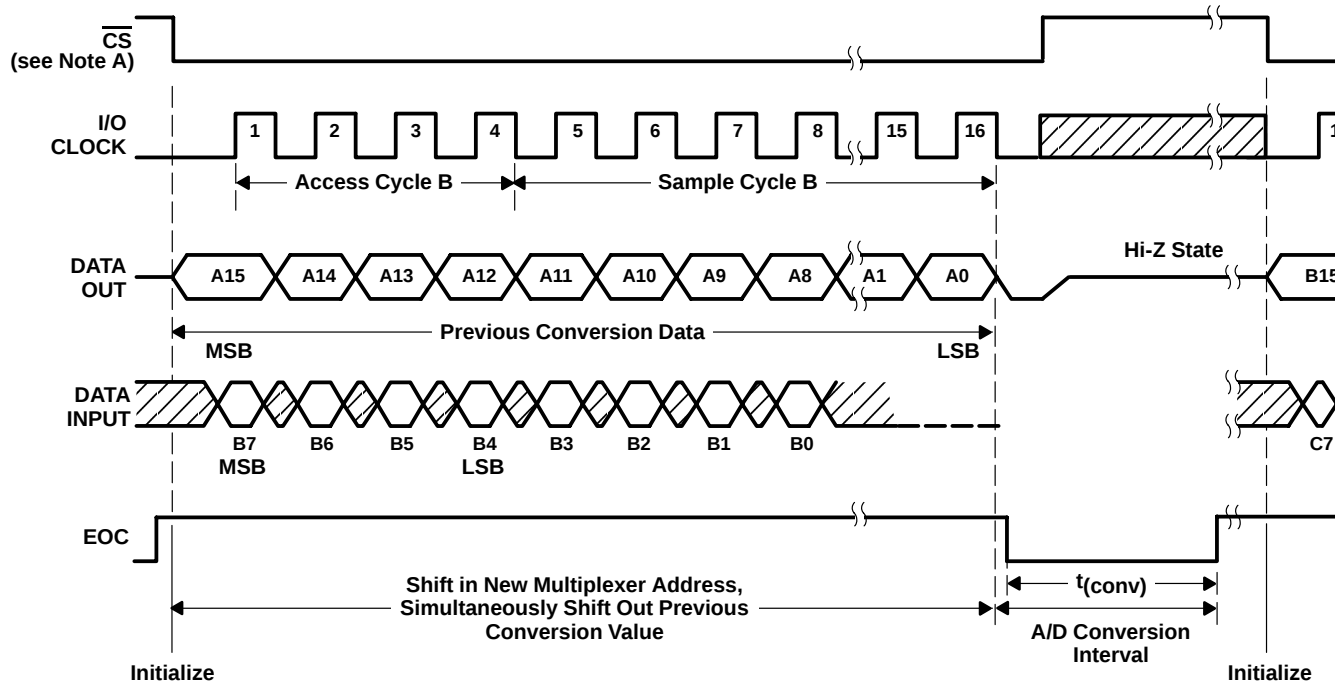
Figure 11. Timing for 8-Clock Transfer Using $\overline{CS}$ With MSB First



NOTE A: To minimize errors caused by noise at $\overline{CS}$, the internal circuitry waits for a setup time after $\overline{CS}\downarrow$ before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum $\overline{CS}$ setup time has elapsed.

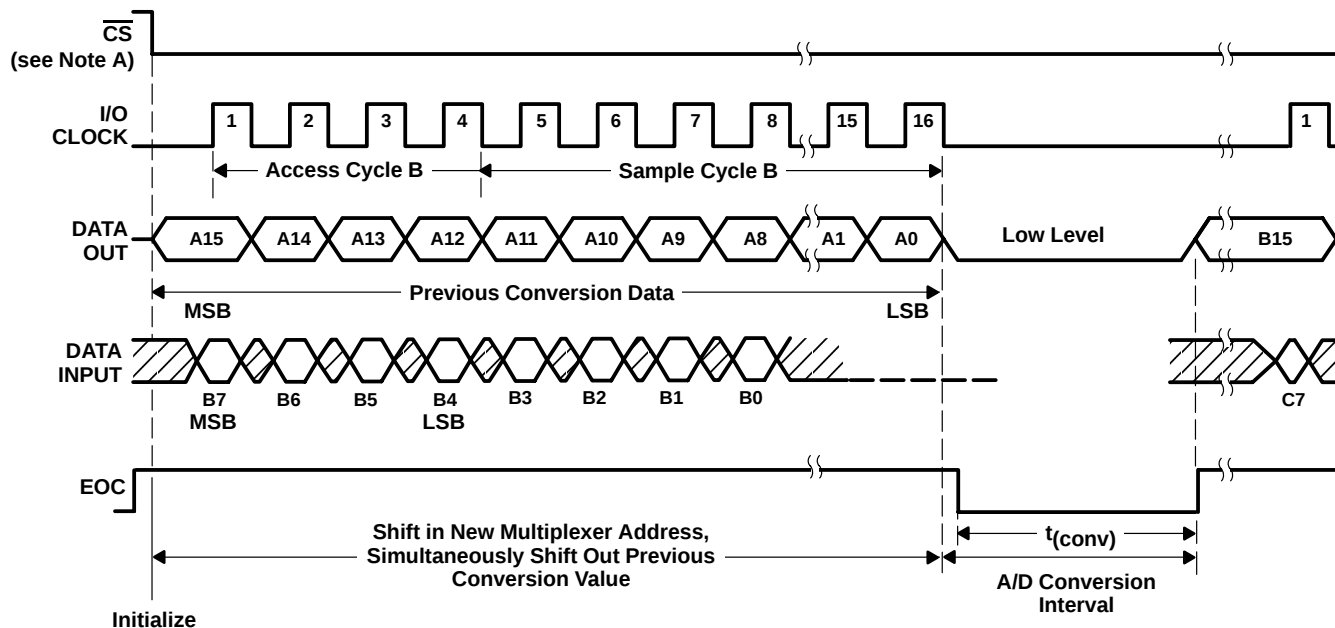
Figure 12. Timing for 8-Clock Transfer Not Using $\overline{CS}$ With MSB First

PARAMETER MEASUREMENT INFORMATION



NOTE A: To minimize errors caused by noise at $\overline{CS}$, the internal circuitry waits for a setup time after $\overline{CS}$ before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum $\overline{CS}$ setup time has elapsed.

Figure 13. Timing for 16-Clock Transfer Using $\overline{CS}$ With MSB First



NOTE A: To minimize errors caused by noise at $\overline{CS}$, the internal circuitry waits for a setup time after $\overline{CS}$ before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum $\overline{CS}$ setup time has elapsed.

Figure 14. Timing for 16-Clock Transfer Not Using $\overline{CS}$ With MSB First

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WITH SERIAL CONTROL AND 11 ANALOG INPUTS

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PRINCIPLES OF OPERATION

Initially, with chip select ($\overline{CS}$) high, I/O CLOCK and DATA INPUT are disabled and DATA OUT is in the high-impedance state. $\overline{CS}$ going low begins the conversion sequence by enabling I/O CLOCK and DATA INPUT and removes DATA OUT from the high-impedance state.

The input data is an 8-bit data stream consisting of a 4-bit analog channel address (D7–D4), a 2-bit data length select (D3–D2), an output MSB or LSB first bit (D1), and a unipolar or bipolar output select bit (D0) that are applied to DATA INPUT. The I/O CLOCK sequence applied to the I/O CLOCK terminal transfers this data to the input data register.

During this transfer, the I/O CLOCK sequence also shifts the previous conversion result from the output data register to DATA OUT. I/O CLOCK receives the input sequence of 8, 12, or 16 clock cycles long depending on the data-length selection in the input data register. Sampling of the analog input begins on the fourth falling edge of the input I/O CLOCK sequence and is held after the last falling edge of the I/O CLOCK sequence. The last falling edge of the I/O CLOCK sequence also takes EOC low and begins the conversion.

converter operation

The operation of the converter is organized as a succession of two distinct cycles: 1) the I/O cycle and 2) the actual conversion cycle.

I/O cycle

The I/O cycle is defined by the externally provided I/O CLOCK and lasts 8, 12, or 16 clock periods, depending on the selected output data length.

During the I/O cycle, the following two operations take place simultaneously.

An 8-bit data stream consisting of address and control information is provided to DATA INPUT. This data is shifted into the device on the rising edge of the first eight I/O CLOCKS. DATA INPUT is ignored after the first eight clocks during 12- or 16-clock I/O transfers.

The data output, with a length of 8, 12, or 16 bits, is provided serially on DATA OUT. When $\overline{CS}$ is held low, the first output data bit occurs on the rising edge of EOC. When $\overline{CS}$ is negated between conversions, the first output data bit occurs on the falling edge of $\overline{CS}$. This data is the result of the previous conversion period, and after the first output data bit, each succeeding bit is clocked out on the falling edge of each succeeding I/O CLOCK.

conversion cycle

The conversion cycle is transparent to the user, and it is controlled by an internal clock synchronized to I/O CLOCK. During the conversion period, the device performs a successive-approximation conversion on the analog input voltage. The EOC output goes low at the start of the conversion cycle and goes high when conversion is complete and the output data register is latched. A conversion cycle is started only after the I/O cycle is completed, which minimizes the influence of external digital noise on the accuracy of the conversion.



PRINCIPLES OF OPERATION

power up and initialization

After power up, $\overline{CS}$ must be taken from high to low to begin an I/O cycle. EOC is initially high, and the input data register is set to all zeroes. The contents of the output data register are random, and the first conversion result should be ignored. To initialize during operation, $\overline{CS}$ is taken high and is then returned low to begin the next I/O cycle. The first conversion after the device has returned from the power-down state may not read accurately due to internal device settling.

Table 1. Operational Terminology

Current (N) I/O cycle	The entire I/O CLOCK sequence that transfers address and control data into the data register and clocks the digital result from the previous conversion from DATA OUT
Current (N) conversion cycle	The conversion cycle starts immediately after the current I/O cycle. The end of the current I/O cycle is the last clock falling edge in the I/O CLOCK sequence. The current conversion result is loaded into the output register when conversion is complete.
Current (N) conversion result	The current conversion result is serially shifted out on the next I/O cycle.
Previous (N–1) conversion cycle	The conversion cycle just prior to the current I/O cycle
Next (N+1) I/O cycle	The I/O period that follows the current conversion cycle

Example: In the 12-bit mode, the result of the current conversion cycle is a 12-bit serial-data stream clocked out during the next I/O cycle. The current I/O cycle must be exactly 12 bits long to maintain synchronization, even when this corrupts the output data from the previous conversion. The current conversion is begun immediately after the twelfth falling edge of the current I/O cycle.

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data input

The data input is internally connected to an 8-bit serial-input address and control register. The register defines the operation of the converter and the output data length. The host provides the data word with the MSB first. Each data bit is clocked in on the rising edge of the I/O CLOCK sequence (see Table 2 for the data input-register format).

Table 2. Input-Register Format

FUNCTION SELECT	INPUT DATA BYTE							
	ADDRESS BITS				L1	L0	LSBF	BIP
	D7 (MSB)	D6	D5	D4	D3	D2	D1	D0 (LSB)
Select input channel								
AIN0 _____	0	0	0	0				
AIN1 _____	0	0	0	1				
AIN2 _____	0	0	1	0				
AIN3 _____	0	0	1	1				
AIN4 _____	0	1	0	0				
AIN5 _____	0	1	0	1				
AIN6 _____	0	1	1	0				
AIN7 _____	0	1	1	1				
AIN8 _____	1	0	0	0				
AIN9 _____	1	0	0	1				
AIN10 _____	1	0	1	0				
Select test voltage								
(V _{ref+} – V _{ref–})/2 _____	1	0	1	1				
V _{ref–} _____	1	1	0	0				
V _{ref+} _____	1	1	0	1				
Software power down _____	1	1	1	0				
Output data length								
8 bits _____					0	1		
12 bits _____					X [†]	0		
16 bits _____					1	1		
Output data format								
MSB first _____							0	
LSB first (LSBF) _____							1	
Unipolar (binary) _____								0
Bipolar (BIP) 2s complement _____								1

[†] X represents a do not care condition.

data input address bits

The four MSBs (D7 – D4) of the data register address one of the 11 input channels, a reference-test voltage, or the power-down mode. The address bits affect the current conversion, which is the conversion that immediately follows the current I/O cycle. The reference voltage is nominally equal to V_{ref+} – V_{ref–}.

PRINCIPLES OF OPERATION

data output length

The next two bits (D3 and D2) of the data register select the output data length. The data-length selection is valid for the current I/O cycle (the cycle in which the data is read). The data-length selection, being valid for the current I/O cycle, allows device start-up without losing I/O synchronization. A data length of 8, 12, or 16 bits can be selected. Since the converter has 12-bit resolution, a data length of 12 bits is suggested.

With D3 and D2 set to 00 or 10, the device is in the 12-bit data-length mode and the result of the current conversion is output as a 12-bit serial data stream during the next I/O cycle. The current I/O cycle must be exactly 12 bits long for proper synchronization, even when this means corrupting the output data from a previous conversion. The current conversion is started immediately after the twelfth falling edge of the current I/O cycle.

With bits D3 and D2 set to 11, the 16-bit data-length mode is selected, which allows convenient communication with 16-bit serial interfaces. In the 16-bit mode, the result of the current conversion is output as a 16-bit serial data stream during the next I/O cycle with the four LSBs always reset to 0 (pad bits). The current I/O cycle must be exactly 16 bits long to maintain synchronization even when this means corrupting the output data from the previous conversion. The current conversion is started immediately after the sixteenth falling edge of the current I/O cycle.

With bits D3 and D2 set to 01, the 8-bit data-length mode is selected, which allows fast communication with 8-bit serial interfaces. In the 8-bit mode, the result of the current conversion is output as an 8-bit serial data stream during the next I/O cycle. The current I/O cycle must be exactly eight bits long to maintain synchronization, even when this means corrupting the output data from the previous conversion. The four LSBs of the conversion result are truncated and discarded. The current conversion is started immediately after the eighth falling edge of the current I/O cycle.

Since D3 and D2 take effect on the current I/O cycle when the data length is programmed, there can be a conflict with the previous cycle when the data-word length is changed from one cycle to the next. This may occur when the data format is selected to be least significant bit first, since at the time the data length change becomes effective (six rising edges of I/O CLOCK), the previous conversion result has already started shifting out.

In actual operation, when different data lengths are required within an application and the data length is changed between two conversions, no more than one conversion result can be corrupted and only when it is shifted out in LSB-first format.

sampling period

During the sampling period, one of the analog inputs is internally connected to the capacitor array of the converter to store the analog input signal. The converter starts sampling the selected input immediately after the four address bits have been clocked into the input data register. Sampling starts on the fourth falling edge of I/O CLOCK. The converter remains in the sampling mode until the eighth, twelfth, or sixteenth falling edge of the I/O CLOCK depending on the data-length selection. After the EOC delay time from the last I/O CLOCK falling edge, the EOC output goes low indicating that the sampling period is over and the conversion period has begun. After EOC goes low, the analog input can be changed without affecting the conversion result. Since the delay from the falling edge of the last I/O CLOCK to EOC low is fixed, time-varying analog input signals can be digitized at a fixed rate without introducing systematic harmonic distortion or noise due to timing uncertainty.

After the 8-bit data stream has been clocked in, DATA INPUT should be held at a fixed digital level until EOC goes high (indicating that the conversion is complete) to maximize the sampling accuracy and minimize the influence of external digital noise.

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data register, LSB first

D1 in the input data register (LSB first) controls the direction of the output binary data transfer. When D1 is reset to 0, the conversion result is shifted out MSB first. When set to 1, the data is shifted out LSB first. Selection of MSB first or LSB first always affects the next I/O cycle and not the current I/O cycle. When changing from one data direction to another, the current I/O cycle is never disrupted.

data register, bipolar format

D0 (BIP) in the input data register controls the binary data format used to represent the conversion result. When D0 is cleared to 0, the conversion result is represented as unipolar (unsigned binary) data. Nominally, the conversion result of an input voltage equal to $V_{\text{ref-}}$ is a code of all zeros (000 . . . 0), the conversion result of an input voltage equal to $V_{\text{ref+}}$ is a code of all ones (111 . . . 1), and the conversion result of $(V_{\text{ref+}} + V_{\text{ref-}})/2$ is a code of a one followed by zeros (100 . . . 0).

When D0 is set to 1, the conversion result is represented as bipolar (signed binary) data. Nominally, conversion of an input voltage equal to $V_{\text{ref-}}$ is a code of a one followed by zeros (100 . . . 0), conversion of an input voltage equal to $V_{\text{ref+}}$ is a code of a zero followed by all ones (011 . . . 1), and the conversion of $(V_{\text{ref+}} + V_{\text{ref-}})/2$ is a code of all zeros (000 . . . 0). The MSB is interpreted as the sign bit. The bipolar data format is related to the unipolar format in that the MSBs are always each other's complement.

Selection of the unipolar or bipolar format always affects the current conversion cycle, and the result is output during the next I/O cycle. When changing between unipolar and bipolar formats, the data output during the current I/O cycle is not affected.

EOC output

The EOC signal indicates the beginning and the end of conversion. In the reset state, EOC is always high. During the sampling period (beginning after the fourth falling edge of the I/O CLOCK sequence), EOC remains high until the internal sampling switch of the converter is safely opened. The opening of the sampling switch occurs after the eighth, twelfth, or sixteenth I/O CLOCK falling edge, depending on the data-length selection in the input data register. After the EOC signal goes low, the analog input signal can be changed without affecting the conversion result.

The EOC signal goes high again after the conversion is completed and the conversion result is latched into the output data register. The rising edge of EOC returns the converter to a reset state and a new I/O cycle begins. On the rising edge of EOC, the first bit of the current conversion result is on DATA OUT when $\overline{\text{CS}}$ is low. When $\overline{\text{CS}}$ is negated between conversions, the first bit of the current conversion result occurs at DATA OUT on the falling edge of $\overline{\text{CS}}$.

data format and pad bits

D3 and D2 of the input data register determine the number of significant bits in the digital output that represent the conversion result. The LSB-first bit determines the direction of the data transfer while the BIP bit determines the arithmetic conversion. The numerical data is always justified toward the MSB in any output format.

The internal conversion result is always 12 bits long. When an 8-bit data transfer is selected, the four LSBs of the internal result are discarded to provide a faster one-byte transfer. When a 12-bit transfer is used, all bits are transferred. When a 16-bit transfer is used, four LSB pad bits are always appended to the internal conversion result. In the LSB-first mode, four leading zeros are output. In the MSB-first mode, the last four bits output are zeros.



PRINCIPLES OF OPERATION

data format and pad bits (continued)

When $\overline{CS}$ is held low continuously, the first data bit of the newly completed conversion occurs on DATA OUT on the rising edge of EOC. When a new conversion is started after the last falling edge of I/O CLOCK, EOC goes low and the serial output is forced to a setting of 0 until EOC goes high again.

When $\overline{CS}$ is negated between conversions, the first data bit occurs on DATA OUT on the falling edge of $\overline{CS}$. On each subsequent falling edge of I/O CLOCK after the first data bit appears, the data is changed to the next bit in the serial conversion result until the required number of bits has been output.

chip-select input ($\overline{CS}$)

$\overline{CS}$ enables and disables the device. During normal operation, $\overline{CS}$ should be low. Although the use of $\overline{CS}$ is not necessary to synchronize a data transfer, it can be brought high between conversions to coordinate the data transfer of several devices sharing the same bus.

When $\overline{CS}$ is brought high, the serial-data output is immediately brought to the high-impedance state, releasing its output data line to other devices that may share it. After an internally generated debounce time, I/O CLOCK is inhibited, thus preventing any further change in the internal state.

When $\overline{CS}$ is subsequently brought low again, the device is reset. $\overline{CS}$ must be held low for an internal debounce time before the reset operation takes effect. After $\overline{CS}$ is debounced low, I/O CLOCK must remain inactive (low) for a minimum time before a new I/O cycle can start.

$\overline{CS}$ can interrupt any ongoing data transfer or any ongoing conversion. When $\overline{CS}$ is debounced low long enough before the end of the current conversion cycle, the previous conversion result is saved in the internal output buffer and shifted out during the next I/O cycle.

power-down features

When a binary address of 1110 is clocked into the input data register during the first four I/O CLOCK cycles, the power-down mode is selected. Power down is activated on the falling edge of the fourth I/O CLOCK pulse.

During power down, all internal circuitry is put in a low-current standby mode. No conversions are performed, and the internal output buffer keeps the previous conversion cycle data results provided that all digital inputs are held above $V_{CC} - 0.5\text{ V}$ or below 0.5 V . The I/O logic remains active so the current I/O cycle must be completed even when the power-down mode is selected. Upon power-on reset and before the first I/O cycle, the converter normally begins in the power-down mode. The device remains in the power-down mode until a valid input address (other than 1110) is clocked in. Upon completion of that I/O cycle, a normal conversion is performed with the results being shifted out during the next I/O cycle.

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analog input, test, and power-down mode

The 11 analog inputs, three internal voltages, and power-down mode are selected by the input multiplexer according to the input addresses shown in Tables 2, 3, and 4. The input multiplexer is a break-before-make type to reduce input-to-input noise rejection resulting from channel switching. Sampling of the analog input starts on the falling edge of the fourth I/O CLOCK and continues for the remaining I/O CLOCK pulses. The sample is held on the falling edge of the last I/O CLOCK pulse. The three internal test inputs are applied to the multiplexer, then sampled and converted in the same manner as the external analog inputs. The first conversion after the device has returned from the power-down state may not read accurately due to internal device settling.

Table 3. Analog-Channel-Select Address

ANALOG INPUT SELECTED	VALUE SHIFTED INTO DATA INPUT	
	BINARY	HEX
AIN0	0000	0
AIN1	0001	1
AIN2	0010	2
AIN3	0011	3
AIN4	0100	4
AIN5	0101	5
AIN6	0110	6
AIN7	0111	7
AIN8	1000	8
AIN9	1001	9
AIN10	1010	A

Table 4. Test-Mode-Select Address

INTERNAL SELF-TEST VOLTAGE SELECTED†	VALUE SHIFTED INTO DATA INPUT		UNIPOLAR OUTPUT RESULT (HEX)‡
	BINARY	HEX	
$\frac{V_{ref+} - V_{ref-}}{2}$	1011	B	800
V_{ref-}	1100	C	000
V_{ref+}	1101	D	FFF

† V_{ref+} is the voltage applied to REF+, and V_{ref-} is the voltage applied to REF-.

‡ The output results shown are the ideal values and may vary with the reference stability and with internal offsets.

Table 5. Power-Down-Select Address

INPUT COMMAND	VALUE SHIFTED INTO DATA INPUT		RESULT
	BINARY	HEX	
Power down	1110	E	$I_{CC} \leq 25 \mu A$

PRINCIPLES OF OPERATION

converter and analog input

The CMOS threshold detector in the successive-approximation conversion system determines each bit by examining the charge on a series of binary-weighted capacitors (see Figure 1). In the first phase of the conversion process, the analog input is sampled by closing the S_C switch and all S_T switches simultaneously. This action charges all the capacitors to the input voltage.

In the next phase of the conversion process, all S_T and S_C switches are opened and the threshold detector begins identifying bits by identifying the charge (voltage) on each capacitor relative to the reference (REF–) voltage. In the switching sequence, 12 capacitors are examined separately until all 12 bits are identified and the charge-convert sequence is repeated. In the first step of the conversion phase, the threshold detector looks at the first capacitor (weight = 4096). Node 4096 of this capacitor is switched to the REF+ voltage, and the equivalent nodes of all the other capacitors on the ladder are switched to REF–. When the voltage at the summing node is greater than the trip point of the threshold detector (approximately $1/2 V_{CC}$), a bit 0 is placed in the output register and the 4096-weight capacitor is switched to REF–. When the voltage at the summing node is less than the trip point of the threshold detector, a bit 1 is placed in the register and this 4096-weight capacitor remains connected to REF+ through the remainder of the successive-approximation process. The process is repeated for the 2048-weight capacitor, the 1024-weight capacitor, and so forth down the line until all bits are determined. With each step of the successive-approximation process, the initial charge is redistributed among the capacitors. The conversion process relies on charge redistribution to determine the bits from MSB to LSB.

reference voltage inputs

The two reference inputs used with the device are the voltages applied to the REF+ and REF– terminals. These voltage values establish the upper and lower limits of the analog input to produce a full-scale and zero-scale reading respectively. These voltages and the analog input should not exceed the positive supply or be lower than ground consistent with the specified absolute maximum ratings. The digital output is at full scale when the input signal is equal to or higher than REF+ terminal voltage and at zero when the input signal is equal to or lower than REF– terminal voltage.

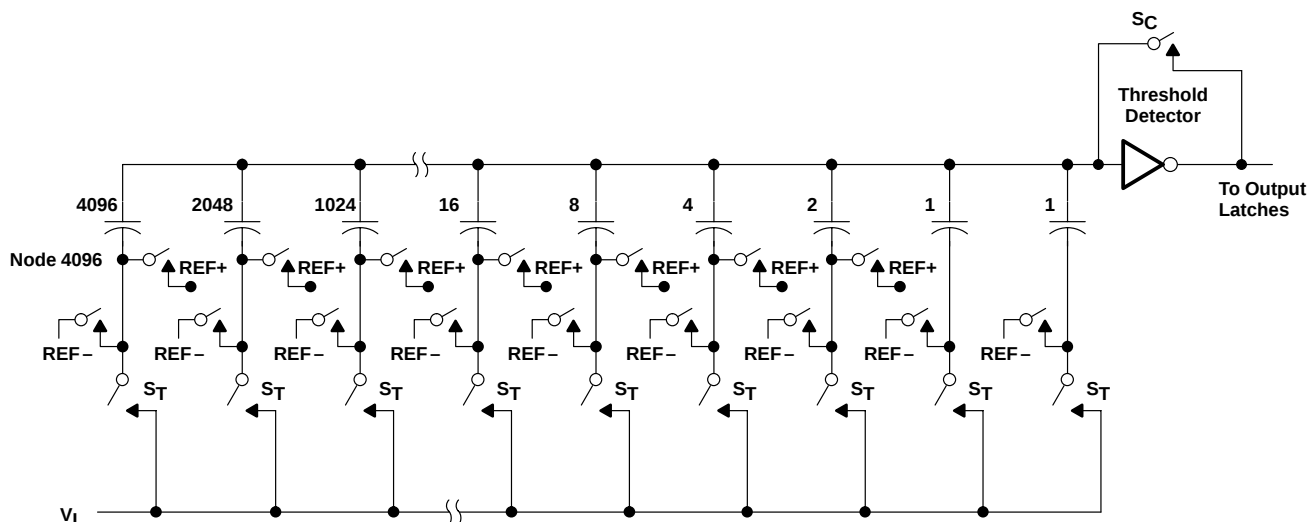


Figure 15. Simplified Model of the Successive-Approximation System

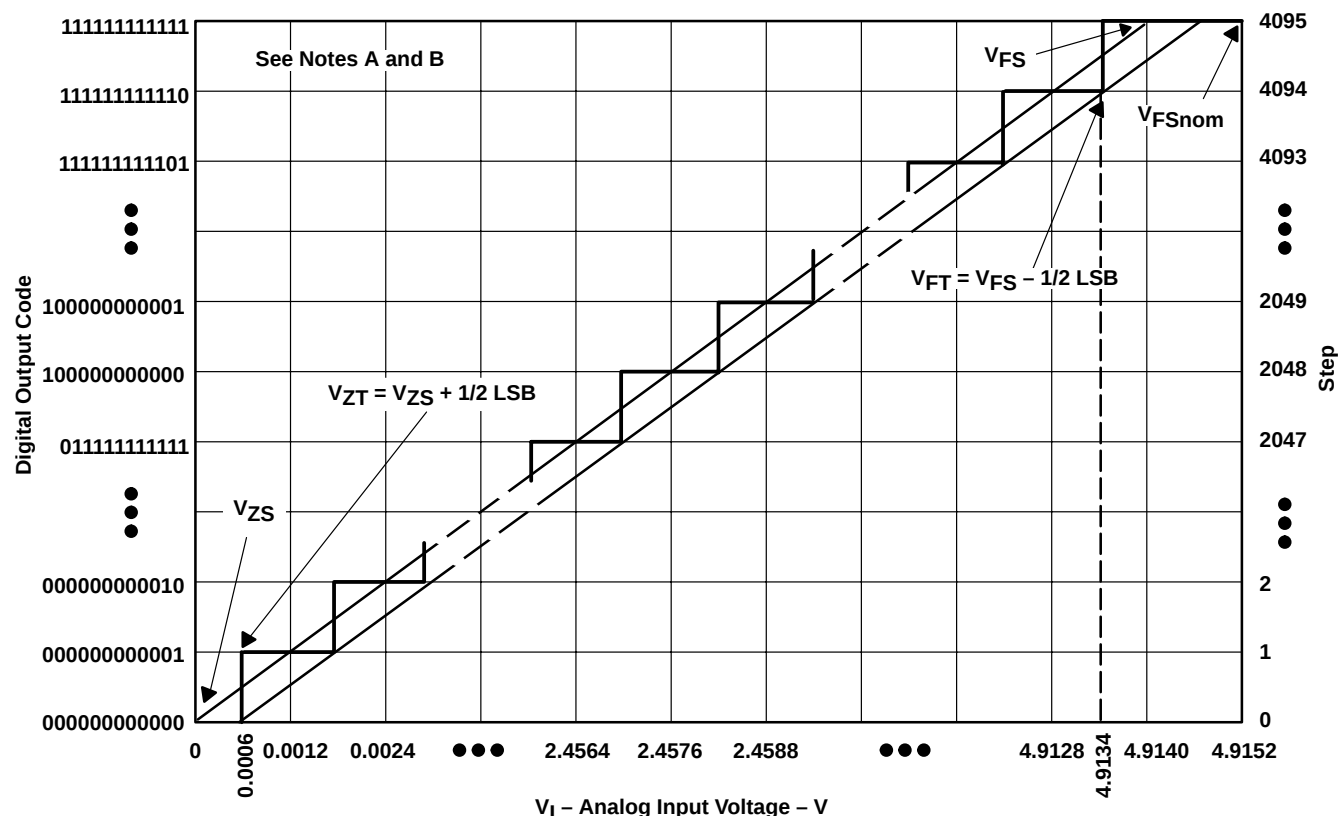
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APPLICATION INFORMATION



- NOTES: A. This curve is based on the assumption that V_{ref+} and V_{ref-} have been adjusted so that the voltage at the transition from digital 0 to 1 (V_{ZT}) is 0.0006 V and the transition to full scale (V_{FT}) is 4.9134 V. 1 LSB = 1.2 mV.
- B. The full-scale value (V_{FS}) is the step whose nominal midstep value has the highest absolute value. The zero-scale value (V_{ZS}) is the step whose nominal midstep value equals zero.

Figure 16. Ideal Conversion Characteristics

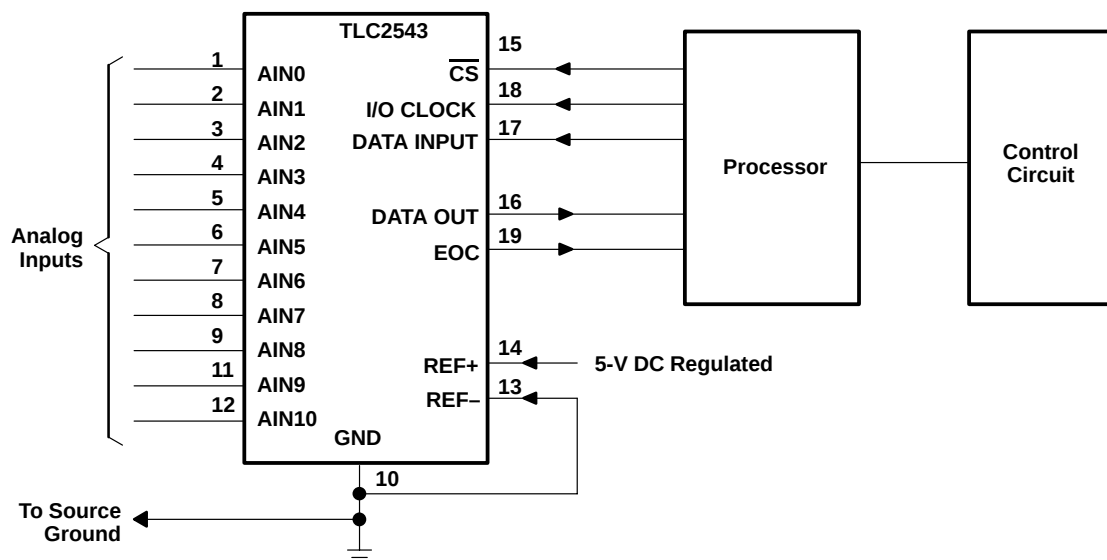


Figure 17. Serial Interface

APPLICATION INFORMATION

simplified analog input analysis

Using the equivalent circuit in Figure 18, the time required to charge the analog input capacitance from 0 V to V_S within 1/2 LSB can be derived as follows:

The capacitance charging voltage is given by

$$V_C = V_S \left(1 - e^{-t_c / R_t C_i} \right) \quad (1)$$

Where:

$$R_t = R_S + r_i$$

The final voltage to 1/2 LSB is given by

$$V_C (1/2 \text{ LSB}) = V_S - (V_S / 8192) \quad (2)$$

Equating equation 1 to equation 2 and solving for time t_c gives

$$V_S - (V_S / 8192) = V_S \left(1 - e^{-t_c / R_t C_i} \right) \quad (3)$$

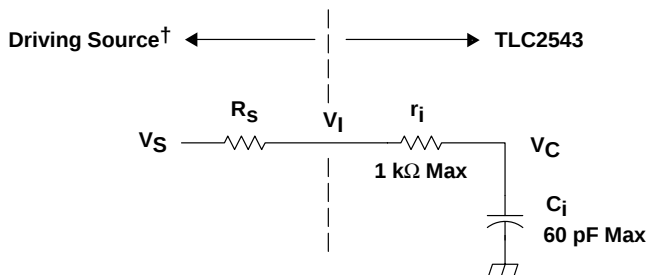
and

$$t_c (1/2 \text{ LSB}) = R_t \times C_i \times \ln(8192) \quad (4)$$

Therefore, with the values given, the time for the analog input signal to settle is

$$t_c (1/2 \text{ LSB}) = (R_S + 1 \text{ k}\Omega) \times 60 \text{ pF} \times \ln(8192) \quad (5)$$

This time must be less than the converter sample time shown in the timing diagrams.



V_I = Input Voltage at AIN
 V_S = External Driving Source Voltage
 R_S = Source Resistance
 r_i = Input Resistance
 C_i = Input Capacitance
 V_C = Capacitance Charging Voltage

† Driving source requirements:

- Noise and distortion for the source must be equivalent to the resolution of the converter.
- R_S must be real at the input frequency.

Figure 18. Equivalent Input Circuit Including the Driving Source

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
5962-9688601QRA	Active	Production	CDIP (J) 20	20 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9688601QR A TLC2543MJB
TLC2543CDB	Active	Production	SSOP (DB) 20	70 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	P2543
TLC2543CDB.A	Active	Production	SSOP (DB) 20	70 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	P2543
TLC2543CDBR	Active	Production	SSOP (DB) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	P2543
TLC2543CDBR.A	Active	Production	SSOP (DB) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	P2543
TLC2543CDW	Active	Production	SOIC (DW) 20	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-	TLC2543C
TLC2543CDW.A	Active	Production	SOIC (DW) 20	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC2543C
TLC2543CDWG4	Active	Production	SOIC (DW) 20	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	See TLC2543CDW	TLC2543C
TLC2543CDWR	Active	Production	SOIC (DW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	TLC2543C
TLC2543CDWR.A	Active	Production	SOIC (DW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC2543C
TLC2543CFN	Obsolete	Production	PLCC (FN) 20	-	-	Call TI	Call TI	-	TLC2543C
TLC2543CN	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	-	TLC2543CN
TLC2543CN.A	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC2543CN
TLC2543IDB	Active	Production	SSOP (DB) 20	70 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-	Y2543
TLC2543IDB.A	Active	Production	SSOP (DB) 20	70 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	Y2543
TLC2543IDBR	Active	Production	SSOP (DB) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	Y2543
TLC2543IDBR.A	Active	Production	SSOP (DB) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	Y2543
TLC2543IDW	Active	Production	SOIC (DW) 20	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-	TLC2543I
TLC2543IDW.A	Active	Production	SOIC (DW) 20	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC2543I
TLC2543IDWG4	Active	Production	SOIC (DW) 20	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	See TLC2543IDW	TLC2543I
TLC2543IDWR	Active	Production	SOIC (DW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	TLC2543I
TLC2543IDWR.A	Active	Production	SOIC (DW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC2543I
TLC2543IDWRG4	Active	Production	SOIC (DW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	See TLC2543IDWR	TLC2543I
TLC2543IFN	Obsolete	Production	PLCC (FN) 20	-	-	Call TI	Call TI	-	TLC2543I
TLC2543IN	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	-	TLC2543IN
TLC2543IN.A	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC2543IN
TLC2543INE4	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	See TLC2543IN	TLC2543IN
TLC2543MJ	Active	Production	CDIP (J) 20	20 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	TLC2543MJ

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLC2543MJ.A	Active	Production	CDIP (J) 20	20 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	TLC2543MJ
TLC2543MJB	Active	Production	CDIP (J) 20	20 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9688601QR A TLC2543MJB
TLC2543MJB.A	Active	Production	CDIP (J) 20	20 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9688601QR A TLC2543MJB

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF TLC2543, TLC2543M :

- Catalog : [TLC2543](#)
- Automotive : [TLC2543-Q1](#), [TLC2543-Q1](#)
- Enhanced Product : [TLC2543-EP](#), [TLC2543-EP](#)
- Military : [TLC2543M](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product - Supports Defense, Aerospace and Medical Applications
- Military - QML certified for Military and Defense Applications

TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC2543CDBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
TLC2543CDWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
TLC2543IDBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
TLC2543IDWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLC2543CDBR	SSOP	DB	20	2000	350.0	350.0	43.0
TLC2543CDWR	SOIC	DW	20	2000	350.0	350.0	43.0
TLC2543IDBR	SSOP	DB	20	2000	350.0	350.0	43.0
TLC2543IDWR	SOIC	DW	20	2000	350.0	350.0	43.0



4214851/B 08/2019

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-150.

EXAMPLE BOARD LAYOUT

DB0020A

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



SOLDER MASK DETAILS

4214851/B 08/2019

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DB0020A

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4214851/B 08/2019

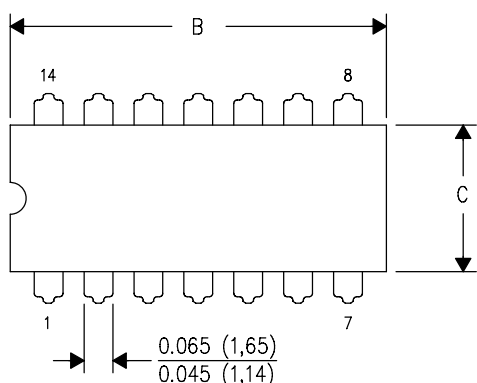
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

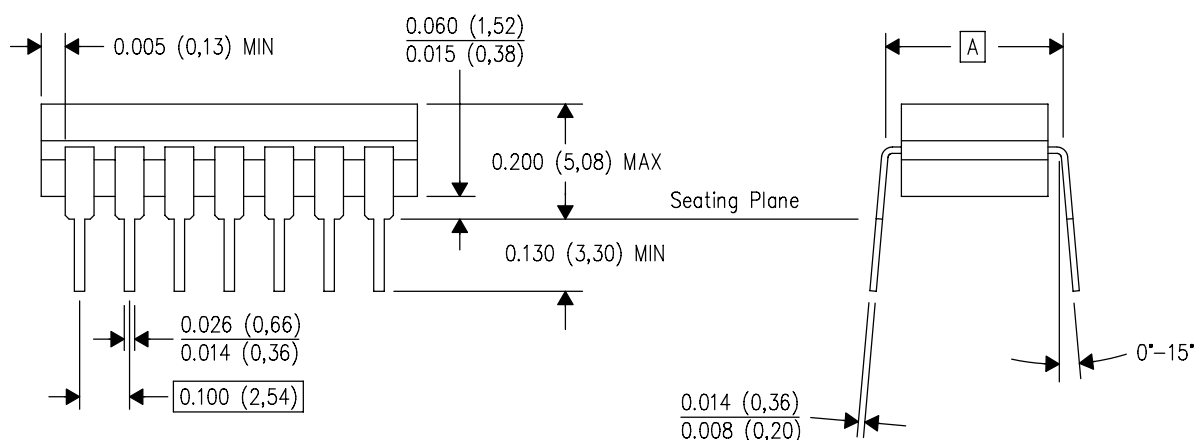
J (R-GDIP-T**)

14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



PINS ** DIM	14	16	18	20
A	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC
B MAX	0.785 (19,94)	.840 (21,34)	0.960 (24,38)	1.060 (26,92)
B MIN	—	—	—	—
C MAX	0.300 (7,62)	0.300 (7,62)	0.310 (7,87)	0.300 (7,62)
C MIN	0.245 (6,22)	0.245 (6,22)	0.220 (5,59)	0.245 (6,22)



4040083/F 03/03

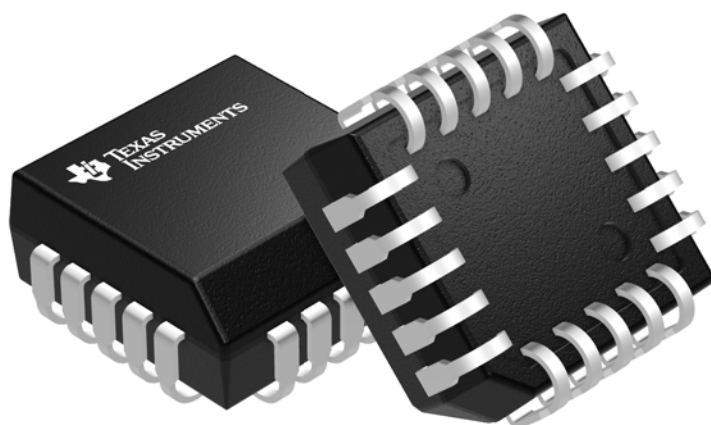
- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. This package is hermetically sealed with a ceramic lid using glass frit.
 - D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
 - E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

FN 20

GENERIC PACKAGE VIEW

PLCC - 4.57 mm max height

PLASTIC CHIP CARRIER



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4040005-2/C



PLCC - 4.57 mm max height

Technical drawing of a 20-pin connector, showing three views: Top, Side, and Front.

Top View:

- Overall width: $.350-.356$ [8.89-9.04] (NOTE 3)
- Overall height: $.350-.356$ [8.89-9.04] (NOTE 3)
- Pin 1 ID (OPTIONAL)
- Pin numbers: 1, 3, 4, 8, 9, 13, 14, 18, 20

Side View:

- Overall height: $.283-.339$ [7.19-8.61]
- Pin height: $.090-.120$ TYP [2.29-3.04]
- Pin pitch: $.026-.032$ [0.66-0.81]
- Seating Plane: $.004$ [0.1] C

Front View:

- Overall width: $.385-.395$ [9.78-10.03] TYP
- Pin pitch: $.026-.032$ [0.66-0.81]
- Feature Control Frame: $\oplus .007$ [0.18] M C A B

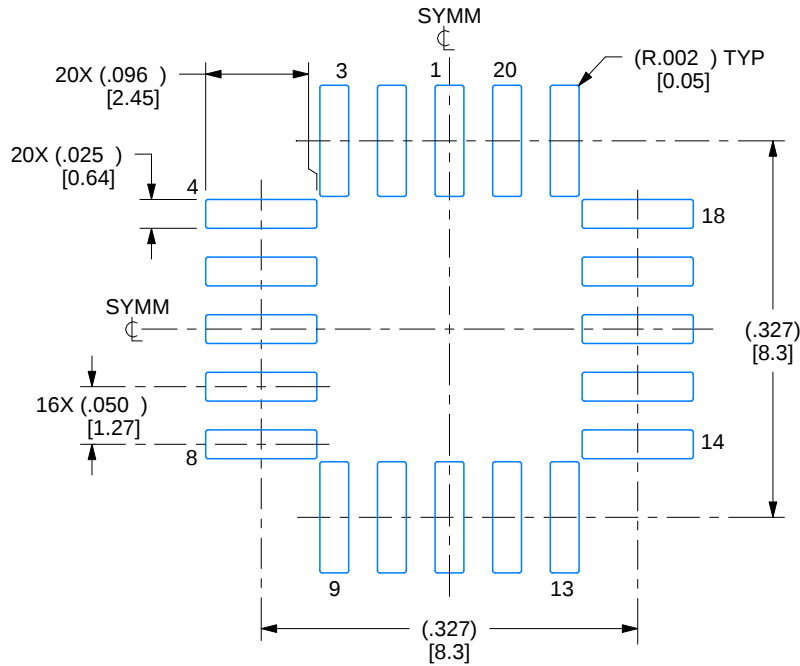
1. All linear dimensions are in inches. Any dimensions in brackets are in millimeters. Any dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Dimension does not include mold protrusion. Maximum allowable mold protrusion .01 in [0.25 mm] per side.
4. Reference JEDEC registration MS-018.

EXAMPLE BOARD LAYOUT

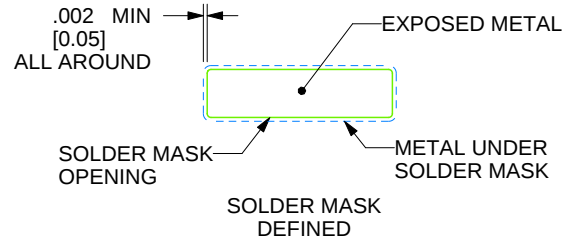
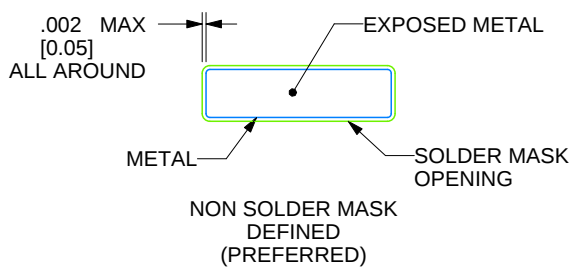
FN0020A

PLCC - 4.57 mm max height

PLASTIC CHIP CARRIER



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:6X



SOLDER MASK DETAILS

4215152/B 04/2017

NOTES: (continued)

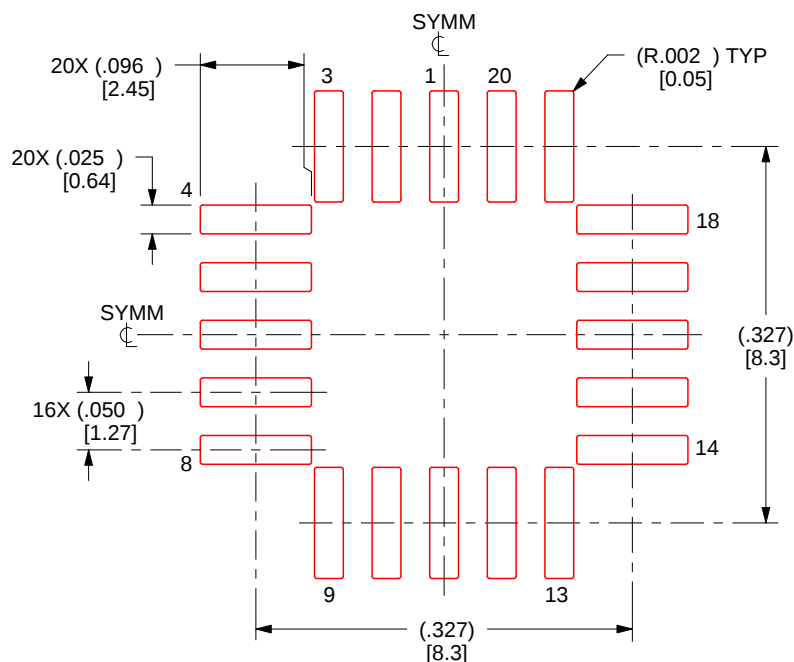
5. Publication IPC-7351 may have alternate designs.
6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

FN0020A

PLCC - 4.57 mm max height

PLASTIC CHIP CARRIER



SOLDER PASTE EXAMPLE
 BASED ON 0.125 mm THICK STENCIL
 SCALE:6X

4215152/B 04/2017

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE

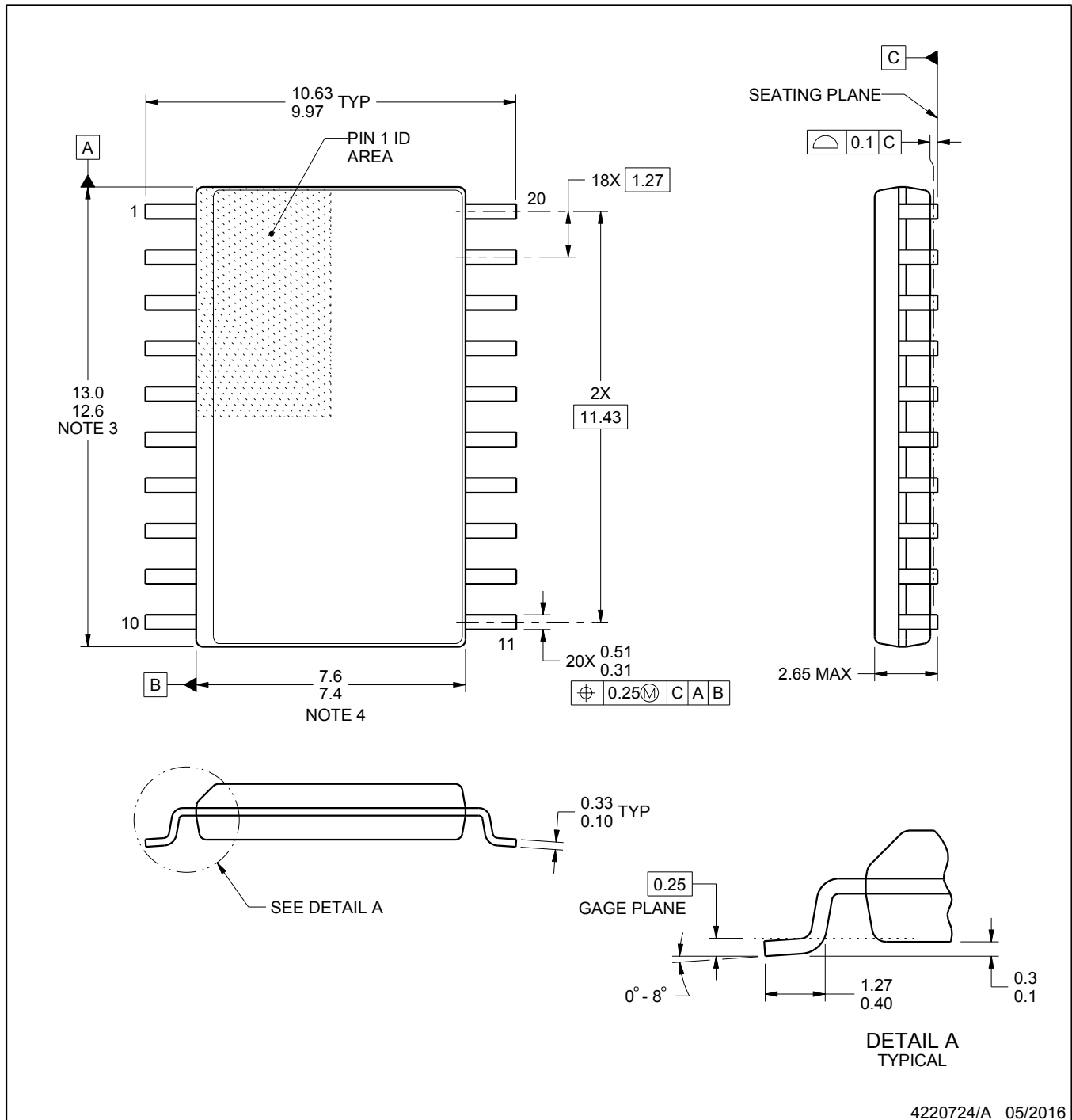
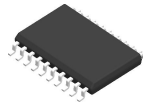


PINS **	14	16	18	20
DIM				
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD



4040049/E 12/2002

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 - The 20 pin end lead shoulder width is a vendor option, either half or full width.



NOTES:

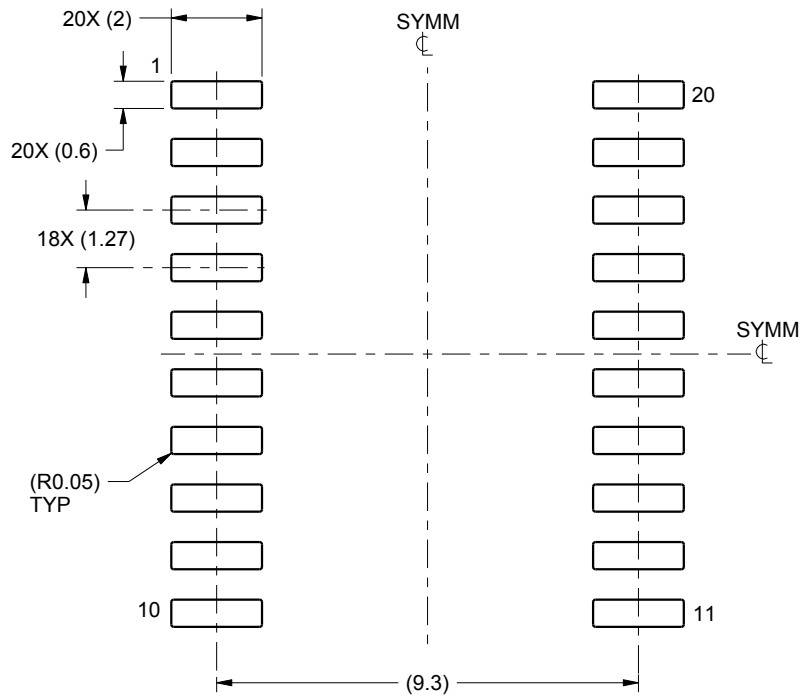
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
5. Reference JEDEC registration MS-013.

EXAMPLE BOARD LAYOUT

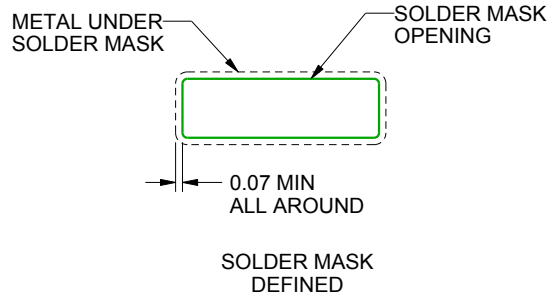
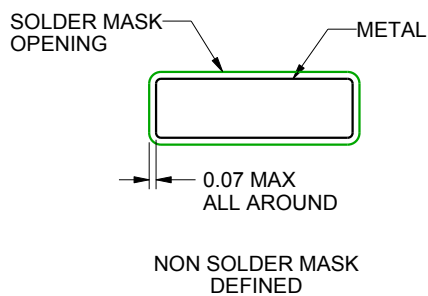
DW0020A

SOIC - 2.65 mm max height

SOIC



LAND PATTERN EXAMPLE
SCALE:6X



SOLDER MASK DETAILS

4220724/A 05/2016

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DW0020A

SOIC - 2.65 mm max height

SOIC



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:6X

4220724/A 05/2016

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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